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Quantitative high dynamic range beam profiling for fluorescence microscopy

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Modern developmental biology relies on optically sectioning fluorescence microscope techniques to produce non-destructive in vivo images of developing specimens at high resolution in three dimensions. As optimal performance of these techniques is reliant on the three-dimensional (3D) intensity profile of the illumination employed, the ability to directly record and analyze these profiles is of great use to the fluorescence microscopist or instrument builder. Though excitation beam profiles can be measured indirectly using a sample of fluorescent beads and recording the emission along the microscope detection path, we demonstrate an alternative approach where a miniature camera sensor is used directly within the illumination beam. Measurements taken using our approach are solely concerned with the illumination optics as the detection optics are not involved. We present a miniature beam profiling device and high dynamic range flux reconstruction algorithm that together are capable of accurately reproducing quantitative 3D flux maps over a large focal volume. Performance of this beam profiling system is verified within an optical test bench and demonstrated for fluorescence microscopy by profiling the low NA illumination beam of a single plane illumination microscope. The generality and success of this approach showcases a widely flexible beam amplitude diagnostic tool for use within the life sciences. © 2014 Author(s). All article content, except where otherwise noted, is licensed under a Creative Commons Attribution 3.0 Unported License. [http://dx.doi.org/10.1063/1.4899208]

I. INTRODUCTION

Fluorescence microscopy is a well-established tool for monitoring the constituent structures within living organisms. The incorporation of fluorescent proteins into genetic structures² in conjunction with the development of optical sectioning techniques³⁻⁶ has allowed processes such as embryonic development and cardiac function to be examined at high spatial-temporal resolution in a non-invasive manner.^{7–11} The sectioning capability of these techniques is adversely affected by deviation from the optimum illumination point-spread-function (PSF). Indirect profiling of the illumination beam has been performed at high resolution using a suspension of fluorescent beads as a sample in various fluorescence microscopes 12-16 allowing precise engineering of the desired PSF. 17,18 However, these measurements are recorded using the detection optics, and as such couple both the illumination and detection beam paths together in the beam profile.

In this paper, we propose and demonstrate a device suitable for profiling the illumination beam of a fluorescence microscope directly that is capable of resolving a wide range of flux over a large volume. We describe an extremely compact waterproof sensor and develop a quantitative high dynamic range (HDR) imaging procedure that overcomes the dynamic range limitations of the sensor; though there has been much work on HDR imaging for photography there has been relatively little on using the technique for quantitative imaging. ^{19,20} We then present the results of using our combined imaging procedure and device to profile the illumina-

tion beam of an optically sectioning fluorescence microscope widely adopted for embryonic development studies: a single-plane illumination microscope (SPIM).²¹ Finally, we discuss the limitations of our system and suggest wider future applications of both the device and the HDR imaging procedure.

II. METHODS

A. Instrument design

A miniature 1 mm \times 1 mm footprint 8-bit CMOS sensor, mounted on FlexPCB and optimized for performance in the visible (Awaiba NanEye 2b²²), was mounted within the compact waterproof housing shown in Fig. 1. A glass cover slip of thickness 170 μ m, used to seal the sensor within the housing, allowed the device to operate in close proximity to short working distance optical components. To allow 3D profiling the mounted sensor was affixed to a compact microtranslation stage (Physik Instrument M111.1²³). The array of the sensor, comprised of 3 μ m \times 3 μ m pitch pixels over a 250pixel \times 250pixel array, covered an active area of 750 μ m \times 750 μ m. CMOS chip architecture ensured the absence of cross-pixel blooming during exposures where pixel saturation occurs.

B. HDR imaging

1. Theory and calibration

Due to the nature of beam foci, namely the high flux concentrated within the focal volume and the comparatively low flux outside of that, our system was required to resolve a wide



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FIG. 1. Photograph (a) and schematic (b) of the compact waterproof mounting solution for the Awaiba NanEye 2b CMOS sensor comprising our beam profiling device.

3.2mm

acrylic rod

1.5mm

range of incident fluxes. While a higher bit-depth sensor could be employed to increase dynamic range, such sensors are currently bulky and do not meet the size constraints placed on the profiling device. As such, we devised a general HDR imaging procedure that could be employed to extend the dynamic range of any sensor. As shown in Fig. 2, the standard dynamic range of a sensor operating at a single exposure does not provide adequate sampling of both high and low fluxes. To overcome this limitation, a sequential exposure imaging procedure can be implemented that improves the sensitivity of the sensor over an extended flux range; at longer exposures, the analogto-digital unit (ADU) bit-depth of a sensor saturates at lower incident fluxes than those causing saturation at shorter exposures, resulting in the sensor dynamic range providing better low-flux resolution. A simulation of this for an 8-bit sensor is presented in Fig. 3.

Calibration of our sensor involved taking sequential exposure images of 9 incident fluxes using an integrating sphere (Avantes, AvaSphere-50) to uniformly illuminate the sensor with light of the appropriate wavelength. To roughly match the 488 nm excitation wavelength of many commonly used fluorophores, e.g., GFP, a blue LED (wavelength 470 nm, linewidth 10 nm) was used as the calibration light source (note: operation of the profiler at different wavelengths, e.g., yellow, green, or red, requires recalibration due to the wavelength dependency of the sensor quantum efficiency). Light from this LED was collected by a plano-convex lens, coupled through a microscope objective lens into the core of a multimode fiber, and then fed into the integrating sphere. Prior to the objective lens a filter mount was installed to house a range of absorptive neutral density (ND) filters. The transmission of each ND filter was used as an analog for the relative incident flux, F. For each incident flux, including F = 1 where no ND

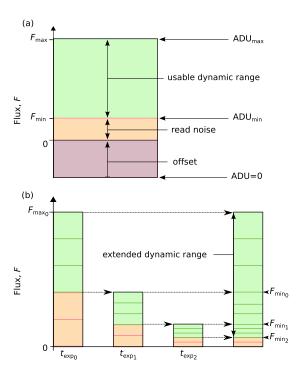


FIG. 2. The dynamic range of a sensor pixel is represented here by a vertical rectangular bar corresponding to the full analog-to-digital unit (ADU) output signal bit-depth (a). The usable region of the dynamic range is affected by offset and read noise, shown as different colored portions of the vertical bar and scaled for emphasis. When a dark image (F = 0) results in an ADU count above zero the ADU headroom has been reduced by the per-pixel offset (purple shading). Above this there is an ADU region that is indistinguishable from the read noise (orange shading) where there is poor resolution between low flux signals. The extent of this region sets the lowest boundary of the usable dynamic range at ADU_{min} , the upper limit of which is set by saturation at ADU_{max}. This usable dynamic range covers a range of incident fluxes that are well-resolved by that sensor pixel for a given exposure. Extension to this range can be achieved through sequential exposure imaging (b). For illustrative purposes the headroom lost due to the offset has been omitted and the range of signals indistinguishable from read noise take up 40% of the total dynamic range. Three successively longer exposures are chosen so that the highest fluxes producing signals lost to read noise are recorded by the usable dynamic range of the next longest exposure. The dynamic range of these three exposures combines to form an extended dynamic range, capable of adequately resolving a wide range of incident fluxes.

filter was present, images were taken using a range of 14 exposures, linearly spaced between 90 μ s and 22.3 ms An offset was applied to the imaging chip to ensure that the dark voltage produced a signal above 0 ADU for all pixels, ensuring no signals were lost at the low end. A gain was also applied to the imaging chip to match the average analogue well saturation level to the maximum output signal of 255 ADU. For each exposure the ADU count for each pixel was taken as the arithmetic mean of 25 images. The resulting response curves exhibited an atypical flux-dependent offset at low exposures (we attributed this to charge retention in the reset circuitry for the photo-diodes comprising each pixel) that followed a soft-knee transition with increasing exposure into a linear region.

We developed a general equation to describe this nonlinear behavior that was then fitted to the response of each pixel. This took the following form:

$$ADU = C_{\alpha} \ln(C_{\beta} F) + \sum_{k=0}^{9} C_k (F \times t_{\exp})^k, \qquad (1)$$

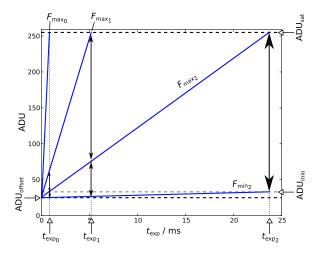


FIG. 3. Demonstration of sequential exposure HDR imaging for a simulated 8-bit sensor pixel exhibiting a linear response to incident flux. The responses to 4 incident flux levels are presented as solid blue lines diverging from a common offset of ADU offset at $t_{\rm exp}=0$. Three exposures are noted: $t_{\rm exp0}$, $t_{\rm exp1}$, and $t_{\rm exp2}$. For all exposures the dynamic range of the sensor ranges from ADU offset up to the saturation signal, ADU sat, shown as horizontal black dashed lines. The presence of read noise, however, dominates low signals and sets a lower limit on the usable dynamic range as the lowest signal distinguishable from read noise, ADU min, presented as a horizontal gray dashed line. Low fluxes that are not well sampled by the dynamic range of the sensor at $t_{\rm exp0}$ can be re-sampled by taking images at longer exposures to improve the signal-to-noise ratio and provide greater distinction between fluxes at the low end. This allows fluxes that were previously indistinguishable from noise to be recovered; fluxes between $F_{\rm max2}$ and $F_{\rm min2}$ that were lost to read noise at $t_{\rm exp0}$ are resolved at $t_{\rm exp2}$.

where the $C_{\alpha, \beta, k}$ are free parameters, $t_{\rm exp}$ is the exposure, and F is the relative incident flux. This allowed the relative incident flux to be calculated from a set of sequential exposure images by numerically solving Eq. (1) using the ADU and $t_{\rm exp}$ from an unsaturated exposure to obtain F. To maximize the SNR and obtain the best estimate of the incident flux we selected the longest unsaturated exposure for each pixel. HDR flux profiles were compiled by performing this process for all pixels, as described in Fig. 4.

2. Verification

The ability of our procedure to reliably construct HDR flux profiles was verified in a test bench setup. A blue Gaussian laser beam (wavelength 488 nm) was fed through a single-mode fiber, then collimated and passed through an iris aperture, which was in turn demagnified by $3 \times$ and focused by a 5 mm diameter achromat lens (Thorlabs AC050-015-A-ML), of focal length of 15 mm, onto the sensor. The iris was used to stop down the beam and enhance the effects of diffraction. A sequence of 10 exposures ranging between 0.2 and 20 ms were taken, ensuring a sufficient dynamic range overlap between subsequent exposures, and the ADU signal for each exposure was taken from the arithmetic mean of 20 images. Equation. (1) was solved numerically for F using Brent's method²⁴ using the longest unsaturated exposure of each pixel. Figure 5(a) presents the flux map resulting from our procedure. In Fig. 5(b), a typical radial line profile outward from the focus is presented alongside the theoretical Airy diffraction pattern for this setup. The HDR line profile displays strong continuous agreement with theory from a relative incident flux of F = 5.8 down to $F \approx 10^{-3}$ where the Airy pattern becomes indistinguishable from noise. Potential improvement to the SNR of our reconstruction at low fluxes is discussed toward the end of Sec. III.

III. RESULTS AND DISCUSSION

Figure 6 shows x-z and y-z sections of a SPIM illumination beam (optical components detailed elsewhere²⁵) profiled by our device. The combined device and translation stage were mounted over the SPIM water tank with the illumination beam (blue laser, wavelength 488 nm) incident on the face of the sensor and images were taken at 90 z-positions over a range of 1 mm along the optical axis of the illumination beam. Our results demonstrate the success of our beam profiler in reconstructing a wide range of fluxes over a volume much larger than the focal region of the beam from a relative magnitude of 10 down to 10^{-3} which allowed us to explore some limitations within our SPIM optical setup. Apparent in both sections are lateral amplitude variations within the beam suggesting that diffraction within the illumination optical train produces a considerable contribution to the beam profile. In addition to this an asymmetric distribution of flux within the beam on either side of the x-z plane focus suggests the illumination beam may not be perfectly aligned to the optical axis of the lenses used. The x-z section also depicts a periodic lateral transit of the beam along z that causes the appearance of this asymmetric distribution to become less clear, though this has been attributed to a lateral motion of the translation stage caused by the rotating leadscrew pitch and has thus been identified as a non-optical effect. The SPIM beam profile showcases a lack of diffraction artifacts outside of the main beam when compared to the test bench beam in Fig. 5 since the test bench beam was intentionally devised to test the dynamic range of our HDR imaging procedure. The lateral resolution of our system is limited by the pitch of the sensor array as the focal width of the light sheet fills only one pixel; the focus is therefore not well-resolved as it is sampled below the Nyquist frequency. However, our large-volume direct beam profile could be combined with a complementary small-volume high-resolution indirect profile recorded though the detection optics using sub-resolution fluorescent beads to overcome this limitation. As the HDR imaging procedure could also be implemented separately on the detection camera system, the dynamic range of the fluorescent bead profile could also be extended and a large-volume composite HDR beam profile could be constructed. Alternatively the direct profile resolution could be improved by using a sensor with a smaller pixel pitch, though at the time of writing there appears to be no miniature CMOS sensors commercially available having considerably smaller pixels than those of our chosen sensor; as such the lateral resolution of our direct beam profiling method is limited by the available technology to the order of around 3 μ m.

The system's profiling capabilities could also be improved by implementing two changes: replacement of the translation stage with one exhibiting less lateral motion, and

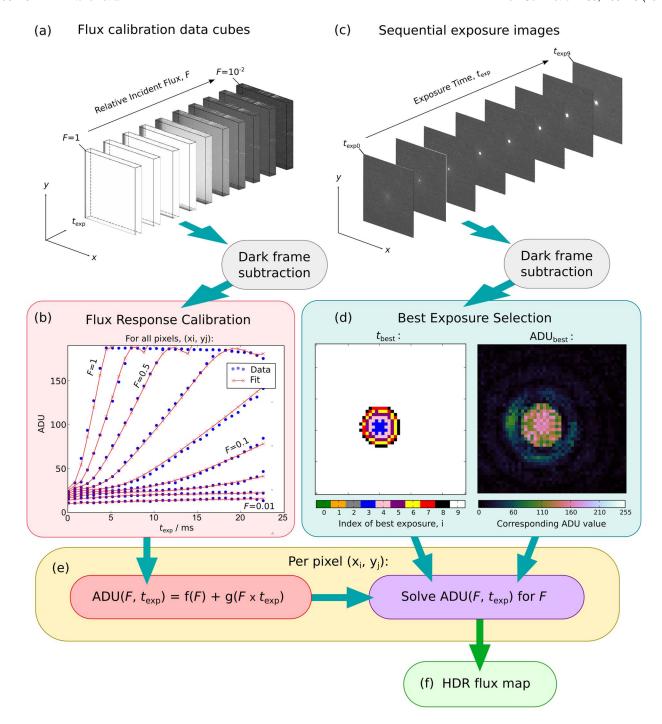


FIG. 4. Flow chart depicting the component processes involved in calibrating our device and composing our HDR flux profiles. Images of uniform illumination are taken over the available range of exposures for a number of different incident fluxes; these form the flux calibration data cubes (a). Following dark frame subtraction a custom polynomial equation is fitted to the calibration data to obtain the time-integrated flux response of each particular pixel. The flux calibration data and fitted response equation are plotted in (b) as blue circles and red curves, respectively. Separately, images are taken of the beam of interest using a sequential range of 10 exposures (c); the index of these exposures runs from 0 for the shortest exposure up to 9 for the longest exposure. After dark frame subtraction the longest exposure resulting in an ADU signal below the saturation threshold is selected for each pixel. The leftmost map within box (d) shows the selected index of best exposure, i.e., the exposure time index having the highest unsaturated ADU signal, for a central region of the input images. The rightmost map in (d) presents the ADU signals corresponding to the longest unsaturated exposure of each pixel within the same region. The best exposure, t_{best} , and signal, ADU_{best}, are then used to solve the response equation for the best estimate of the incident flux at each pixel, $F(x_i, y_j)$ (e). Once this process has been followed for all pixels the full flux map is compiled (f).

expansion of the sequential imaging procedure through the use of longer exposures. Although the axial resolution of our resulting 3D reconstruction was intentionally coarse in order to demonstrate the wide range of fluxes across the beam focus that could be reconstructed by our system, there are

many higher-precision translation stages that could be used instead. The dynamic range of our reconstruction procedure was limited by the longest exposure available in the camera control software. The use of a wider range of sequential exposures in both imaging and the calibration of the sensor would

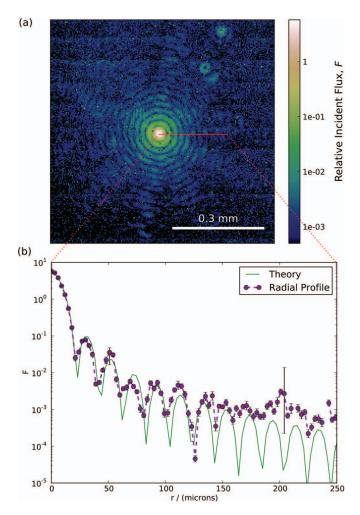


FIG. 5. Verification of our procedure by comparing the HDR flux map of a laser beam focus (presented in false-color, (a)) with the theoretical Airy pattern present (b). Logarithmic scales are used for both figures. The radial line profile in (b) demonstrates the capacity of our procedure to resolve a wide and continuous range of fluxes that are several orders of magnitude below the maximum recorded incident flux. Error bars correspond to the standard error on the ADUs used to determine incident flux.

improve the SNR of low fluxes, providing a much broader beam profiling capability and potentially allowing extremely faint diffraction artifacts to be revealed.

Based on the high quality flux mapping demonstrated in the test bench set up we believe that our system will be of great utility in profiling a variety of beam geometries. As the components of our profiling system are simple and compact, and the calibration and HDR imaging solution presented are general and flexible, we propose that devices similar to ours can be constructed and implemented with ease by those wishing to directly profile beams within any fluorescence microscope system. The ability of our system to record accurate amplitude profiles either side of a beam focus may be well-suited to phase diversity (PD) techniques, such as the Gerchberg-Saxton algorithm, to determine the aberrations present in the illumination beam. PD could also be used to resolve the beam shape at the focus by first calculating the complex field at each intensity plane and then propagating the computed complex waveform of the beam from either input plane to the focal position.

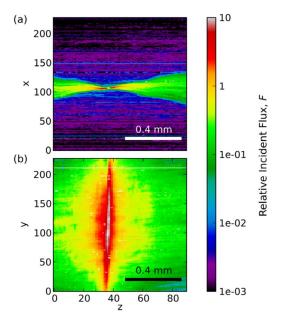


FIG. 6. Logarithmic false color x-z (a), and y-z (b) sections through a 3-D HDR flux profile of a SPIM illumination beam within a water tank. The range of flux values have been assigned relative to those used in calibrating the system and are presented on a logarithmic color bar. The x and y scales correspond to pixel coordinates across the sensor; the z scale refers to the coordinates of each slice within the image stack along the optical axis—the closest plane to the focusing lens is at z = 0.

In short, the system is capable of profiling low-power visible-wavelength beams and thus may find alternative applications outside of the microscope, e.g., the foci of fibercoupling assemblies or animal ocular lenses to name just two suggestions.

IV. SUMMARY

We have developed a HDR beam profiler intended for use within the life sciences and demonstrated its functionality within an optically sectioning fluorescence microscope. The system hardware is comprised of a miniature 8-bit CMOS sensor embedded within a minimally-invasive waterproof housing. Software has been developed that employs sequential exposure imaging to calibrate the sensor and allow the reconstruction of continuous HDR flux profiles with a dynamic range of over 5×10^3 : 1. The correctness of this HDR reconstruction procedure has been verified by profiling a low NA beam undergoing broad diffraction and the system has been used to explore the optical limitations of a SPIM. Though the performance of the device is limited by presently available technology, our HDR flux reconstruction procedure is highly general and thus not limited to our specific hardware. The application of our device to fluorescence microscopy can also be extended to allow wavefront determination using PD techniques and may even find use outside of the microscope in determining the optical performance of fiber-coupling assemblies or animal ocular specimens.

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